Search Notes					

Application/Control No.	Applicant(s)/Patent under Reexamination
10/748,215	OYA, TAKESHI
Examiner	Art Unit
Bryan Bui	2863

	SEAR	CHED	
Class	Subclass	Date	Examiner
702	182 183 184 186 188	6/1/2005	ВВ
709	217 218 219	6/2/2005	BB
	223 224		
			1

INT	ERFERENC	E SEARCH	ED
Class	Subclass	Date	Examiner
702	182 184 188	6/3/2005	ВВ
709	218 224	6/3/2005	ВВ

SEAI (INCLUDING S	RCH NOTES SEARCH STRATEG	Y)
	DATE	EXMR
east	6/2/2005	ВВ
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